Renesas Electronics America Inc - R7FS7G27H3A01CFB#AA0 Datasheet

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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	240MHz
Connectivity	CANbus, EBI/EMI, Ethernet, I²C, IrDA, MMC/SD, QSPI, SCI, SPI, SSI, UART/USART, USB
Peripherals	DMA, LCD, LVD, POR, PWM, WDT
Number of I/O	104
Program Memory Size	4MB (4M x 8)
Program Memory Type	FLASH
EEPROM Size	64K x 8
RAM Size	640K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 3.6V
Data Converters	A/D 19x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LQFP
Supplier Device Package	144-LFQFP (20x20)
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r7fs7g27h3a01cfb-aa0

1. Overview

The S7G2 MCU integrates multiple series of software- and pin-compatible ARM®-based 32-bit MCUs that share the same set of Renesas peripherals to facilitate design scalability and efficient platform-based product development.

The MCU provides a high-performance ARM Cortex®-M4 core running up to 240 MHz with the following features:

- Up to 4-MB code flash memory
- 640-KB SRAM
- Graphics LCD Controller (GLCDC)
- 2D Drawing Engine (DRW)
- Capacitive Touch Sensing Unit (CTSU)
- Ethernet MAC Controller (ETHERC) with IEEE 1588 PTP, USBFS, USBHS, SD/MMC Host Interface
- Quad Serial Peripheral Interface (QSPI)
- Security and safety features
- Analog peripherals.

1.1 Function Outline

Table 1.1 ARM core

Feature	Functional description
ARM Cortex-M4	• Maximum operating frequency: up to 240 MHz • ARM Cortex-M4 core: - Revision: r0p1-01rel0 - ARMv7E-M architecture profile - Single precision floating point unit compliant with the ANSI/IEEE Std 754-2008 • ARM Memory Protection Unit (MPU): - ARMv7 Protected Memory System Architecture - 8 protect regions • SysTick timer: - Driven by LOCO clock

Table 1.2 Memory

Feature	Functional description
Code flash memory	Maximum 4 MB of code flash memory. See section 54, Flash Memory in User's Manual.
Data flash memory	64 KB of data flash memory. See section 54, Flash Memory in User's Manual.
Memory Mirror Function (MMF)	The MMF can be configured to mirror the wanted application image load address in code flash memory to the application image link address in the 23-bit unused memory space (memory mirror space addresses). Your application code is developed and linked to run from this MMF destination address. The application code does not need to know the load location where it is stored in code flash memory. See section 5, Memory Mirror Function (MMF) in User's Manual.
SRAM	On-chip high-speed SRAM providing either parity-bit or double-bit error detection (DED). The first 32 KB of SRAM0 is subject to DED. Parity check is performed for other areas. See section 52, SRAM in User's Manual.
Standby SRAM	On-chip SRAM that can retain data in Deep Software Standby mode. See section 53, Standby SRAM in User's Manual.

Table 1.3 System (1/2)

Feature	Functional description
Operating modes	Two operating modes: - Single-chip mode - SCI or USB boot mode. See section 3, Operating Modes in User's Manual.

1.3 Part Numbering

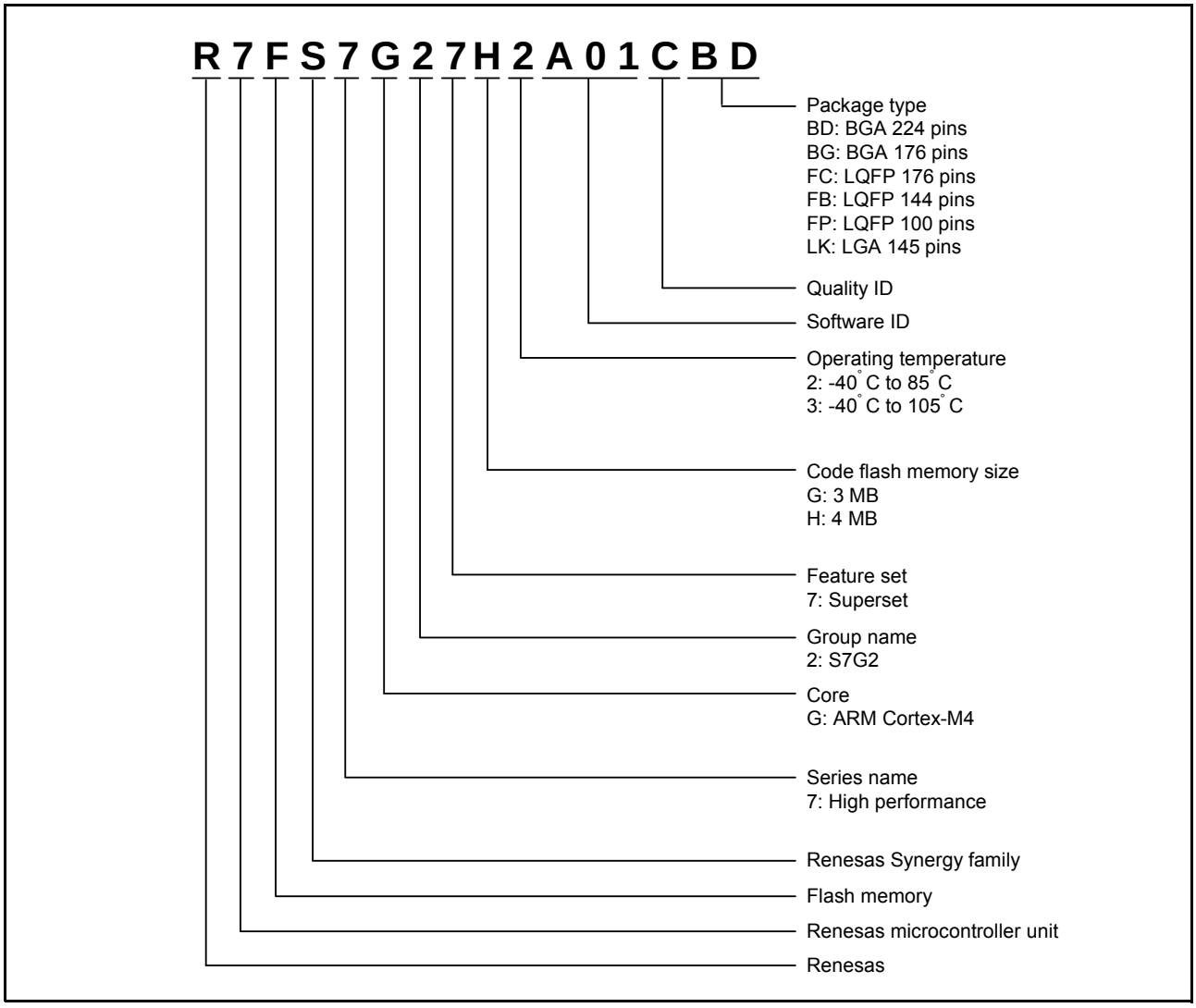


Figure 1.2 Part numbering scheme

1.5 Pin Functions

Table 1.16 Pin functions (1/5)

Function	Signal	I/O	Description
Power supply	VCC	Input	Power supply pin. Connect to the system power supply. Connect this pin to VSS through a 0.1-µF capacitor. Place the capacitor close to the pin.
	VCC_DCDC	Input	Switching regulator power supply pin.
	VLO	I/O	Switching regulator pin.
	VCL0 to VCL2	Input	Connect this pin to VSS through the smoothing capacitor used to stabilize the internal power supply. Place the capacitor close to the pin.
	VCL_F	Input	
	VSS	Input	Ground pin. Connect to the system power supply (0 V).
	VBATT	Input	Backup power pin.
Clock	XTAL	Output	Pins for a crystal resonator. An external clock signal can be input through the EXTAL pin.
	EXTAL	Input	
	XCIN	Input	Input/output pins for the sub-clock oscillator. Connect a crystal resonator between XCOUT and XCIN.
	XCOUT	Output	
	EBCLK	Output	Outputs the external bus clock for external devices.
	SDCLK	Output	Outputs the SDRAM-dedicated clock.
	CLKOUT	Output	Clock output pin.
Operating mode control	MD	Input	Pins for setting the operating mode. The signal levels on these pins must not be changed during operation mode transition on release from the reset state.
System control	RES	Input	Reset signal input pin. The MCU enters the reset state when this signal goes low.
CAC	CACREF	Input	Measurement reference clock input pin.
On-chip emulator	TMS	I/O	On-chip emulator or boundary scan pins.
	TDI	Input	
	TCK	Input	
	TDO	Output	
	TCLK	Output	This pin outputs the clock for synchronization with the trace data.
	TDATA0 to TDATA3	Output	These pins indicate that output from the TDATA0 to TDATA3 pins is valid.
	SWDIO	I/O	Serial wire debug data input/output pin.
	SWCLK	Input	Serial wire clock pin.
	SWO	Output	Serial wire trace output pin.
External bus interface	RD	Output	Strobe signal indicating that reading from the external bus interface space is in progress, active LOW.
	WR	Output	Strobe signal indicating that writing to the external bus interface space is in progress, in 1-write strobe mode, active LOW.
	WR0, WR1	Output	Strobe signals indicating that either group of data bus pins (D07 to D00 or D15 to D08) is valid in writing to the external bus interface space, in byte strobe mode, active LOW.
	BC0, BC1	Output	Strobe signals indicating that either group of data bus pins (D07 to D00 or D15 to D08) is valid in access to the external bus interface space, in 1-write strobe mode, active LOW.
	WAIT	Input	Input pin for wait request signals in access to the external space, active LOW.
	CS0 to CS7	Output	Select signals for CS areas, active LOW.
	A00 to A23	Output	Address bus.
	D00 to D15	I/O	Data bus.

Table 1.16 Pin functions (4/5)

Function	Signal	I/O	Description
ETHERC	REF50CK0, REF50CK1	Input	50-MHz reference clocks. These pins input reference signals for transmission/reception timing in RMII mode.
	RMII0_CRS_DV, RMII1_CRS_DV	Input	Indicate carrier detection signals and valid receive data on RMII_RXD1 and RMII_RXD0 in RMII mode.
	RMII0_TXD0, RMII0_TXD1, RMII1_TXD0, RMII1_TXD1	Output	2-bit transmit data in RMII mode.
	RMII0_RXD0, RMII0_RXD1, RMII1_RXD0, RMII1_RXD1	Input	2-bit receive data in RMII mode.
	RMII0_TXD_EN, RMII1_TXD_EN	Output	Output pins for data transmit enable signals in RMII mode.
	RMII0_RX_ER, RMII1_RX_ER	Input	Indicate an error occurred during reception of data in RMII mode.
	ET0_CRS, ET1_CRS	Input	Carrier detection/data reception enable signals.
	ET0_RX_DV, ET1_RX_DV	Input	Indicate valid receive data on ET_ERXD3 to ET_ERXD0.
	ET0_EXOUT, ET1_EXOUT	Input	General-purpose external output pins.
	ET0_LINKSTA, ET1_LINKSTA	Output	Input link status from the PHY-LSI.
	ET0_ETXD0 to ET0_ETXD3, ET1_ETXD0 to ET1_ETXD3	output	4 bits of MII transmit data.
	ET0_ERXD0 to ET0_ERXD3, ET1_ERXD0 to ET1_ERXD3	Input	4 bits of MII receive data.
	ET0_TX_EN, ET1_TX_EN	Output	Transmit enable signals. Function as signals indicating that transmit data is ready on ET_ETXD3 to ET_ETXD0.
	ET0_TX_ER, ET1_TX_ER	Output	Transmit error pins. Function as signals notifying the PHY_LSI of an error during transmission.
	ET0_RX_ER, ET1_RX_ER	Input	Receive error pins. Function as signals to recognize an error during reception.
	ET0_TX_CLK, ET1_TX_CLK	Input	Transmit clock pins. These pins input reference signals for output timing from ET_TX_EN, ET_ETXD3 to ET_ETXD0, and ET_TX_ER.
	ET0_RX_CLK, ET1_RX_CLK	Input	Receive clock pins. These pins input reference signals for input timing to ET_RX_DV, ET_ERXD3 to ET_ERXD0, and ET_RX_ER.
	ET0_COL, ET1_COL	Input	Input collision detection signals.
	ET0_WOL, ET1_WOL	Output	Receive Magic packets.
	ET0_MDC, ET1_MDC	Output	Output reference clock signals for information transfer through ET_MDIO.
	ET0_MDIO, ET1_MDIO	I/O	Input or output bidirectional signals for exchange of management data with PHY-LSI.
SDHI	SD0CLK, SD1CLK	Output	SD clock output pin.
	SD0CMD, SD1CMD	I/O	Command output pin and response input signal pin.
	SD0DAT0 to SD0DAT7, SD1DAT0 to SD1DAT7	I/O	SD and MMC data bus pins.
	SD0CD, SD1CD	Input	SD card detection pin.
	SD0WP, SD1WP	Input	SD write-protect signal.

Table 1.17 Pin list (6/12)

Pin number						Power, System, Clock, Debug,	I/O port	Extbus		Timers				Communication interfaces											Analog		HMI		
BGA224	BGA176	LQFP176	LGA145	LQFP144	LQFP100			External bus	SDRAM	AGT	GPT	GPT	RTC	USBFS, CAN	SCI0,2,4,6,8 (30 MHz)	SCI1,3,5,7,9 (30 MHz)	IIC	SPI, QSPI	SSI	MII (25 MHz)	RMII (50 MHz)	USBHS	SDHI	ADC12	DAC12, ACMPHS	CTSU	Interrupt	GLCDC, PDC
E7	D8	70	-	-	-	-	P908	CS7	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA14_B
F7	D7	71	-	-	-	-	P907	CS6	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA13_B
F6	A7	72	-	-	-	-	P906	CS5	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA12_B
A6	B7	73	-	-	-	-	P905	CS4	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA11_B
B6	C7	74	C6	58	-	-	P312	CS3	CAS	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
C7	D6	75	B5	59	-	-	P311	CS2	RAS	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA23_A
A4	-	-	-	-	-	VSS	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
B4	-	-	-	-	-	VCC	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
C6	A6	76	D7	60	-	-	P310	A15	A15	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA22_A
C5	B6	77	A5	61	-	-	P309	A14	A14	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA21_A
D7	A5	78	C5	62	-	-	P308	A13	A13	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA20_A
D6	C6	79	A4	63	41	-	P307	A12	A12	-	-	-	-	-	CTS6_RTS6_A/SS6_A	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA19_A
D5	A4	80	B4	64	42	-	P306	A11	A11	-	-	-	-	-	SCK6_A	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA18_A
D4	B5	81	D6	65	43	-	P305	A10	A10	-	-	-	-	-	TXD6_A/MOSI6_A/SDA6_A	-	-	-	-	-	-	-	-	-	-	-	IRQ8	LCD_DATA17_A
C4	B4	82	C4	66	44	-	P304	A09	A09	-	-	GTIOC7A_A	-	-	RXD6_A/MISO6_A/SCL6_A	-	-	-	-	-	-	-	-	-	-	-	-	IRQ9	LCD_DATA16_A
A5	C5	83	A3	67	45	VSS	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
B5	D5	84	B3	68	46	VCC	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
E6	-	-	-	-	-	-	P915	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA20_B
E5	-	-	-	-	-	-	P914	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	LCD_DATA19_B

Table 1.17 Pin list (11/12)

Pin number						Power, System, Clock, Debug,	I/O port	Extbus		Timers				Communication interfaces										Analog		HMI		
BGA224	BGA176	LQFP176	LGA145	LQFP144	LQFP100			External bus	SDRAM	AGT	GPT	GPT	RTC	USBFS, CAN	SCI0,2,4,6,8 (30 MHz)	SCI1,3,5,7,9 (30 MHz)	IIC	SPI, QSPI	SSI	MII (25 MHz)	RMII (50 MHz)	USBHS	SDHI	ADC12	DAC12, ACMPHS	CTSU	Interrupt	GLCDC, PDC
P5	N5	143	K5	116	79	-	P503	-	-	-	GETRGC_B	GTIOC12B	-	USB_EXICEN_B	CTS6_RTS6_B/SS6_B	SCK5_A	-	QIO1	-	-	-	-	SD1DAT1	AN117	-	-		-
R5	P5	144	L5	117	80	-	P504	-	-	-	GETRGD_B	GTIOC13A	-	USB_ID_B	SCK6_B	CTS5_RTS5_A/SS5_A		QIO2	-	-	-	-	SD1DAT2	AN018	-	-		-
M5	P6	145	K6	118	-	-	P505	-	-	-	-	GTIOC13B	-	-	RXD6_B/MISO6_B/SCL6_B	-	-	QIO3	-	-	-	-	SD1DAT3	AN118	-	-	IRQ14	-
M6	R5	146	L6	119	-	-	P506	-	-	-	-	-	-	-	TXD6_B/MOSI6_B/SDA6_B	-	-	-	-	-	-	-	SD1CD	AN019	-	-	IRQ15	-
N6	N6	147	-	-	-	-	P507	-	-	-	-	-	-	-		CTS5_RTS5_B/SS5_B	-	-	-	-	-	-	SD1WP	AN119	-	-	-	-
M7	-	-	-	-	-	-	P508	-	-	-	-	-	-	-		SCK5_B	-	-	-	-	-	-	-	AN020	-	-	-	-
P6	-	-	-	-	-	-	P509	-	-	-	-	-	-	-		TXD5_B/MOSI5_B/SDA5_B	-	-	-	-	-	-	-	AN120	-	-	-	-
N7	-	-	-	-	-	-	P510	-	-	-	-	-	-	-	-	RXD5_B/MISO5_B/SCL5_B	-	-	-	-	-	-	-	AN021	-	-	-	-
R6	R6	148	N4	120	81	VCL2	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
P7	M7	149	N5	121	82	VCC	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
R7	N7	150	M5	122	83	VSS	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
M8	P7	151	M6	123	84	-	P015	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	AN006/AN106	DA1/IVCMP1	-	IRQ13	-
M9	R7	152	N6	124	85	-	P014	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	AN005/AN105	DA0/IVREF3	-	-	-
N8	P8	153	M7	125	86	VREFL	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
R8	R8	154	N7	126	87	VREFH	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
P8	N8	155	L7	127	88	AVCC0	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
N9	N9	156	L8	128	89	AVSS0	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
P9	P9	157	M8	129	90	VREFL0	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-
R9	R9	158	N8	130	91	VREFH0	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-	-

Note 1. This is the value when low driving ability is selected in the port drive capability bit in the PmnPFS register. The selected driving ability is retained in Deep Software Standby mode.
Note 2. This is the value when middle driving ability is selected in the port drive capability bit in the PmnPFS register. The selected driving ability is retained in Deep Software Standby mode.
Note 3. This is the value when high driving ability is selected in the port drive capability bit in the PmnPFS register. When the following ports are configured for high driving ability, they shift to middle driving ability during Deep Software Standby mode: P203 to P207, P407 to P415, P602, P708 to P713, P813, PA12 to PA15, PB01.
Note 4. Except for P000 to P007, P200, which are input ports.

2.2.4 I/O V_{OH}, V_{OL}, and Other Characteristics

Table 2.6 I/O V_{OH}, V_{OL}, and other characteristics

Item		Symbol	Min	Typ	Max	Unit	Test conditions
Output voltage	IIC*1	V_{OL}	-	-	0.4	V	I_{OL} = 3.0 mA
		V_{OL}	-	-	0.6		I_{OL} = 6.0 mA
	IIC*2	V_{OL}	-	-	0.4		I_{OL} = 15.0 mA (ICFER.FMPE = 1)
		V_{OL}	-	0.4	-		I_{OL} = 20.0 mA (ICFER.FMPE = 1)
	ETHERC	V_{OH}	VCC – 0.5	-	-		I_{OH} = –1.0 mA
		V_{OL}	-	-	0.4		I_{OL} = 1.0 mA
	Ports P205, P206, P407 to P415, P602, P708 to P713, P813, PA12 to PA15, PB01 (total 24 pins)*3	V_{OH}	VCC – 1.0	-	-		I_{OH} = –20 mA VCC = 3.3 V
		V_{OL}	-	-	1.0		I_{OL} = 20 mA VCC = 3.3 V
	Other output pins	V_{OH}	VCC – 0.5	-	-		I_{OH} = –1.0 mA
		V_{OL}	-	-	0.5		I_{OL} = 1.0 mA
Input leakage current	RES	$\|I_{in}\|$	-	-	5.0	µA	V_{in} = 0 V V_{in} = 5.5 V
	Ports P000 to P007, P200		-	-	1.0		V_{in} = 0 V V_{in} = VCC
Three-state leakage current (off state)	5V-tolerant ports	$\|I_{TSI}\|$	-	-	5.0	µA	V_{in} = 0 V V_{in} = 5.5 V
	Other ports (except for ports P000 to P007, P200)		-	-	1.0		V_{in} = 0 V V_{in} = VCC
Input pull-up MOS current	Ports P0 to PB (except for ports P000 to P007)	I_p	–300	-	–10	µA	VCC = 2.7 to 3.6 V V_{in} = 0 V
Input capacitance	USB_DP, USB_DM, and ports P003, P007, P014, P015,P400, P415, P401, P511, P512	C_{in}	-	-	16	pF	Vbias = 0V Vamp = 20mV f = 1 MHz T_a = 25°C
	Other input pins		-	-	8		

Note 1. SCL0_B, SDA0_B, SCL1_A, SDA1_A, SCL1_B, SDA1_B, SCL2, SDA2 (total 8 pins).
Note 2. SCL0_A, SDA0_A (total 2 pins).
Note 3. This is the value when high driving ability is selected in the port drive capability bit in the PmnPFS register. Even when high driving ability is selected, I_{OH} and I_{OL} shift to middle driving ability during Deep Software Standby mode.

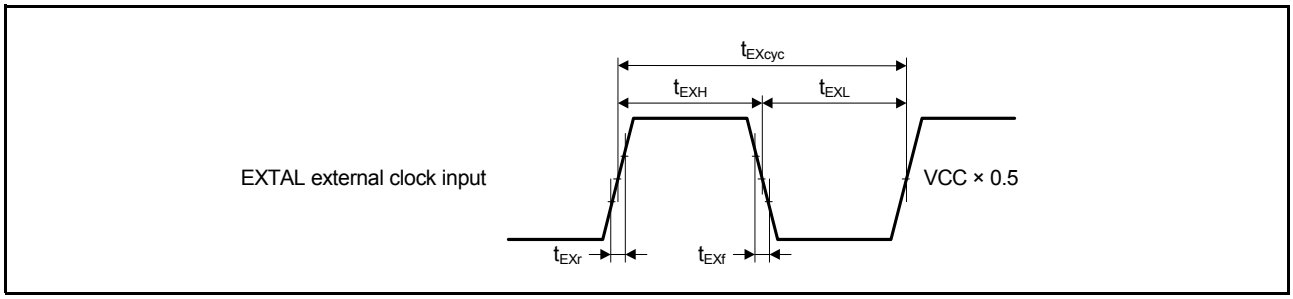


Figure 2.4 EXTAL external clock input timing

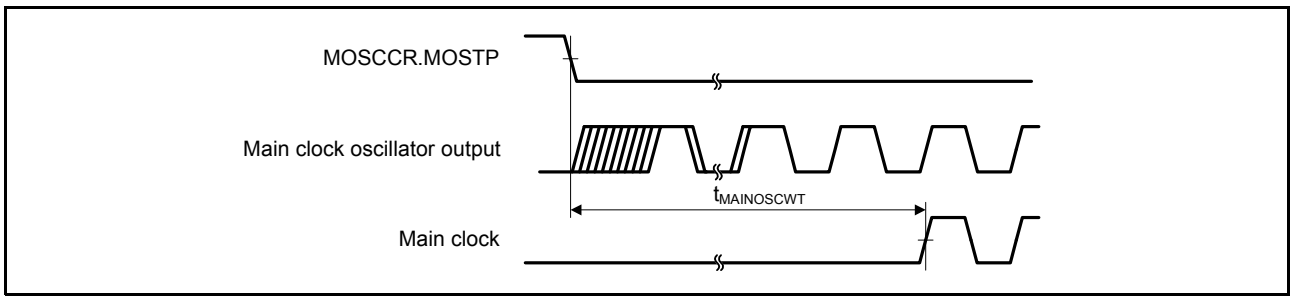


Figure 2.5 Main clock oscillation start timing

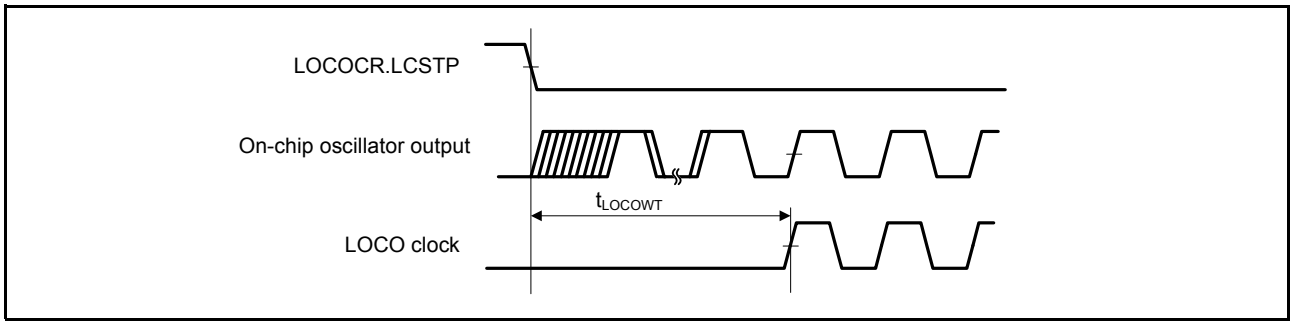


Figure 2.6 LOCO clock oscillation start timing

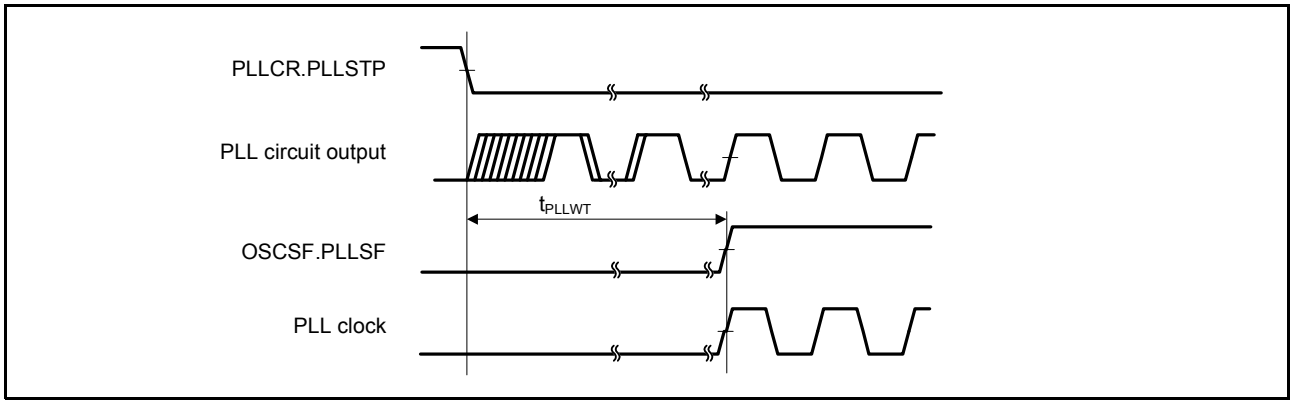


Figure 2.7 PLL clock oscillation start timing

Note: Only operate the PLL is operated after main clock oscillation has stabilized.

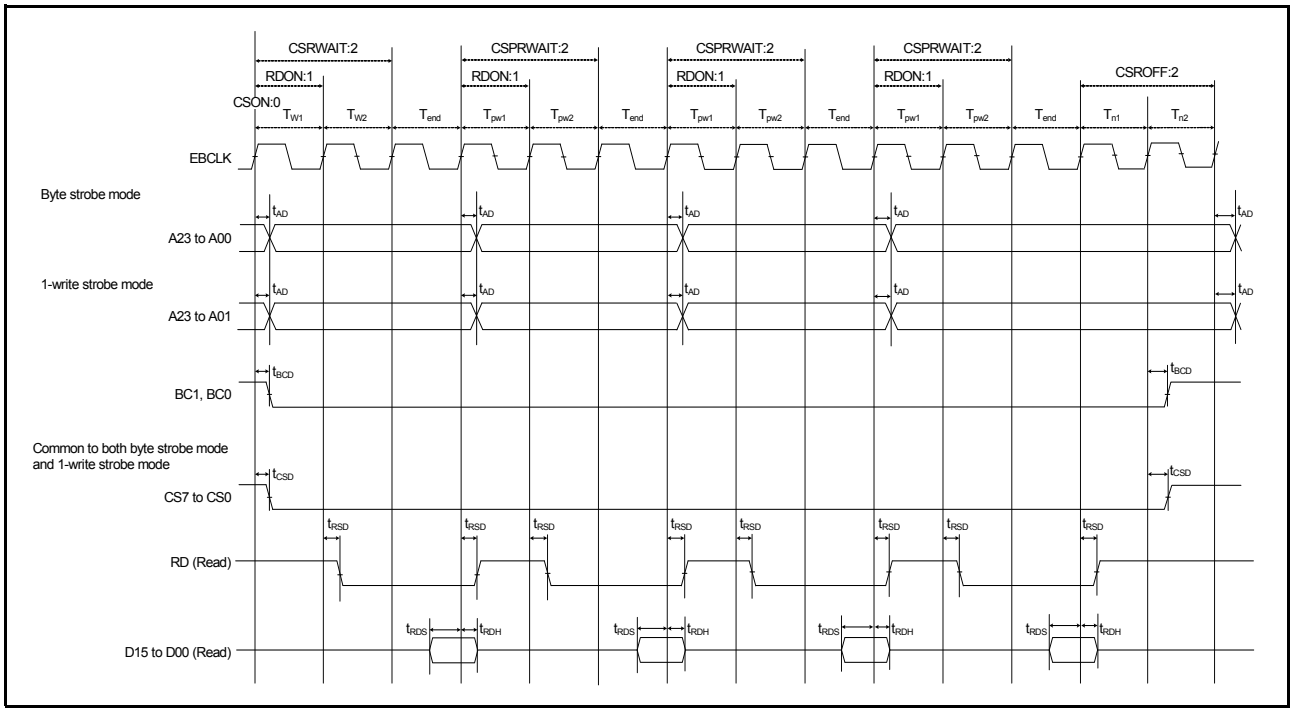
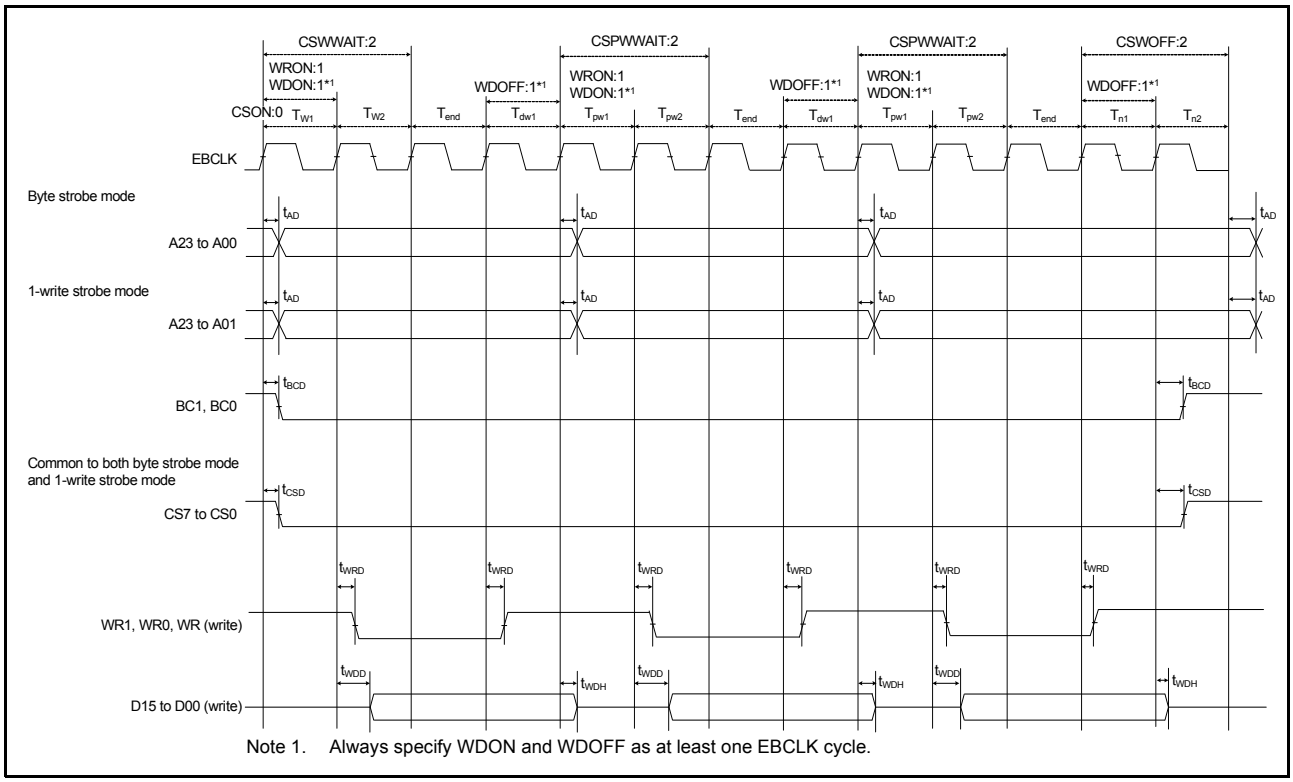
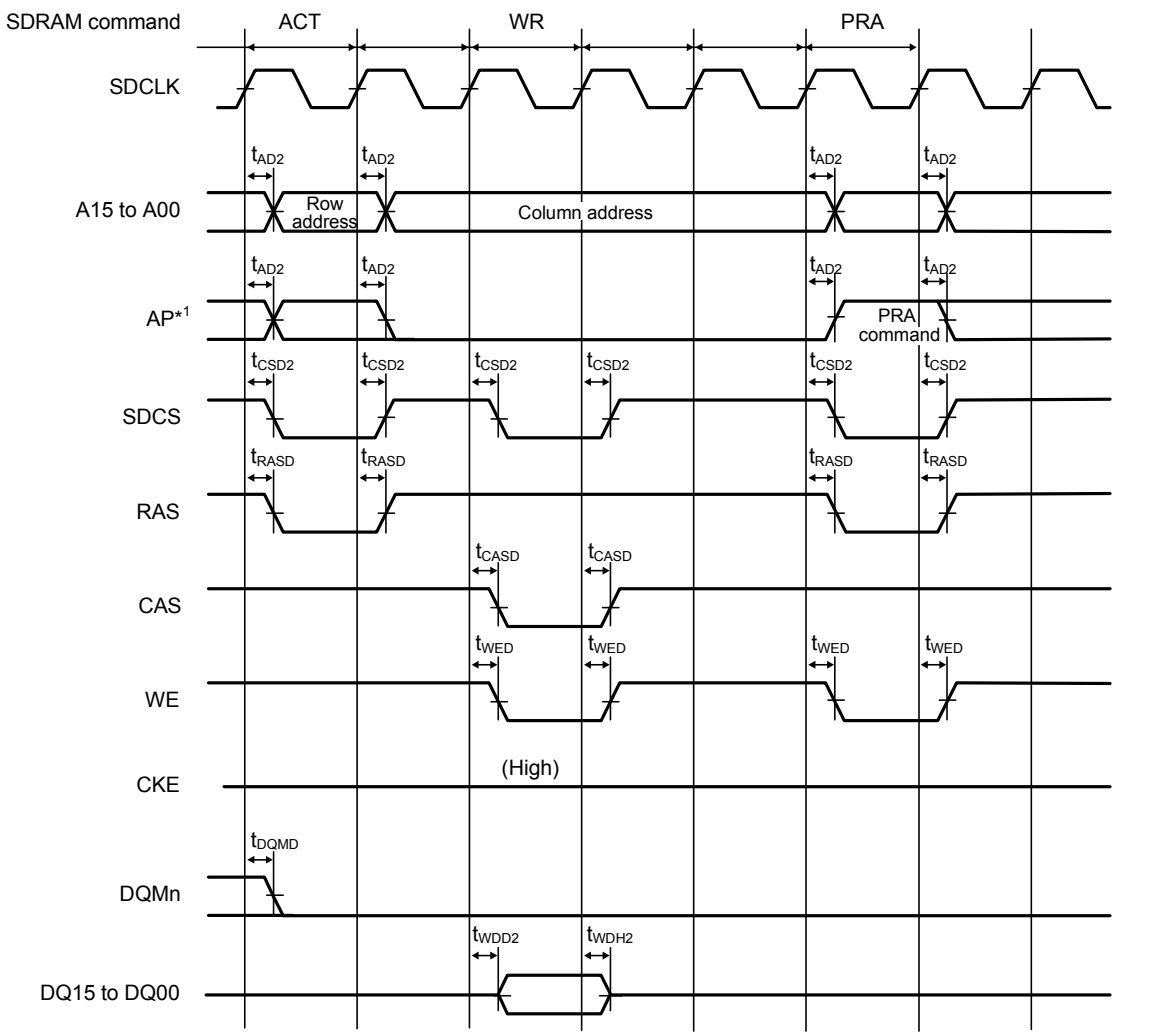


Figure 2.16 External bus timing for page read cycle with bus clock synchronized



Note 1. Always specify WDON and WDOFF as at least one EBCLK cycle.

Figure 2.17 External bus timing for page write cycle with bus clock synchronized



Note 1. Address pins are for output of the precharge-select command (Precharge-sel) for the SDRAM.

Figure 2.20 SDRAM single write timing

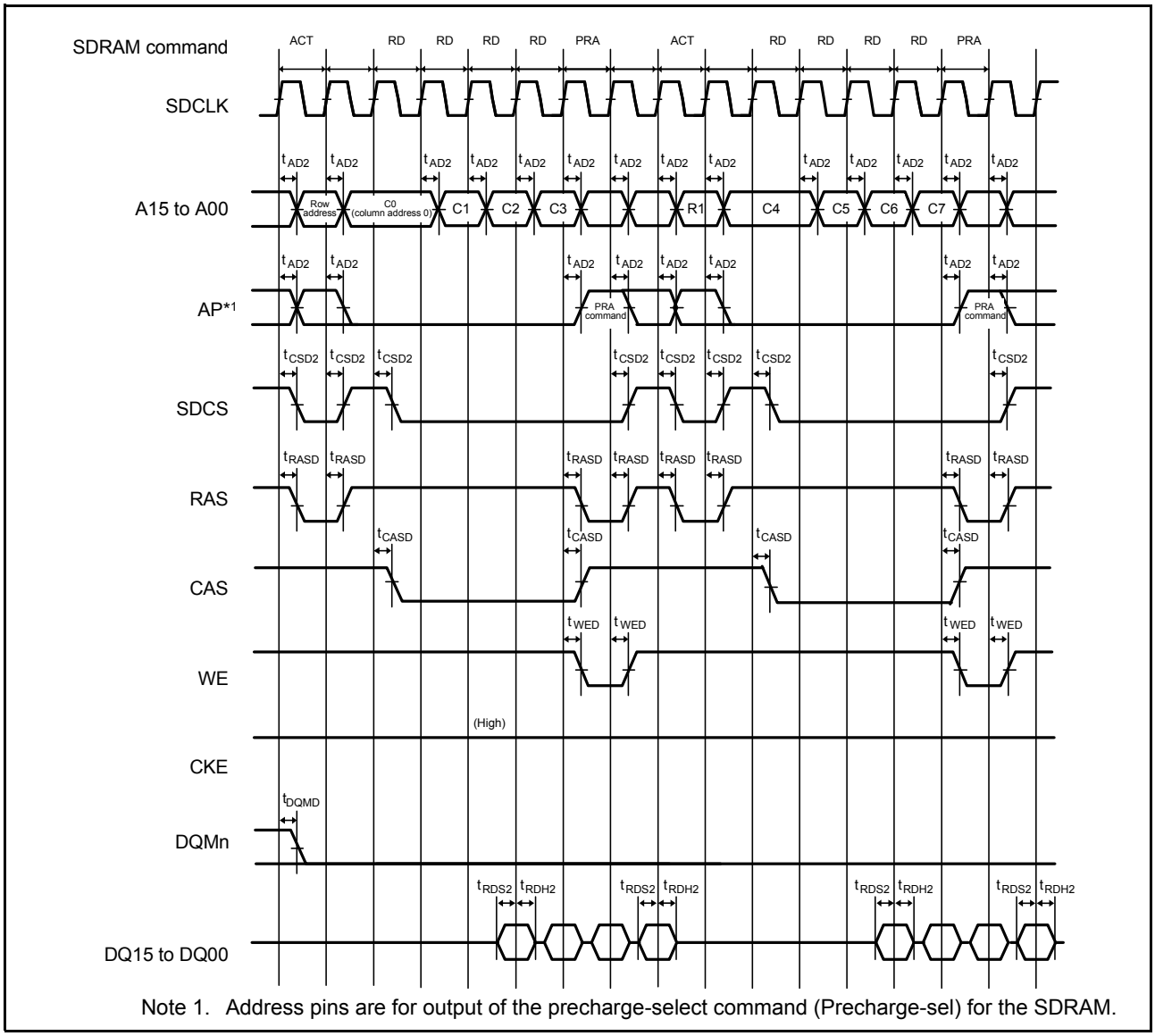


Figure 2.23 SDRAM multiple read line stride timing

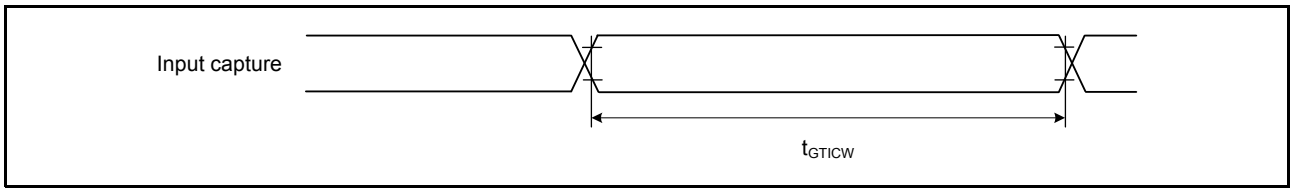


Figure 2.28 GPT32 input capture timing

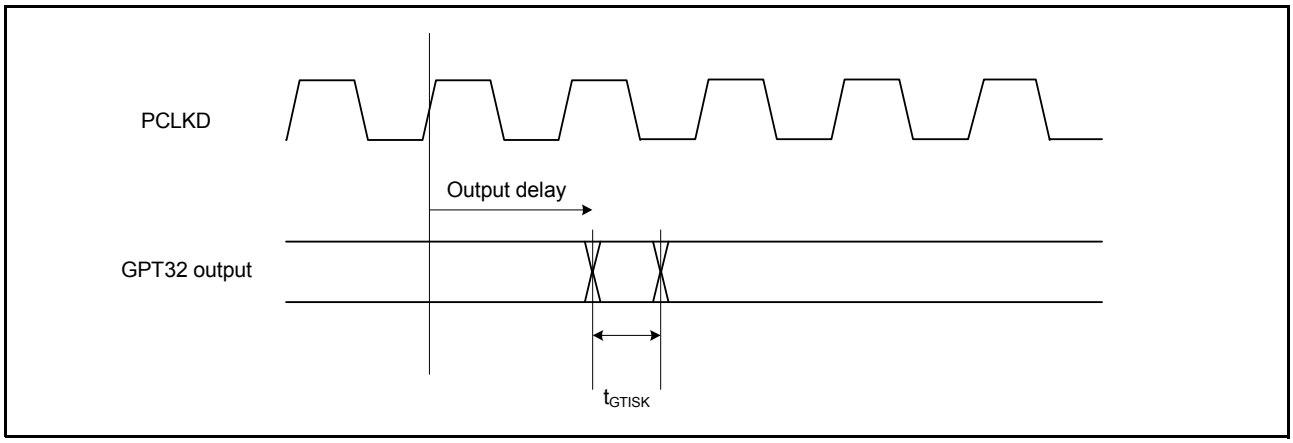


Figure 2.29 GPT32 output delay skew

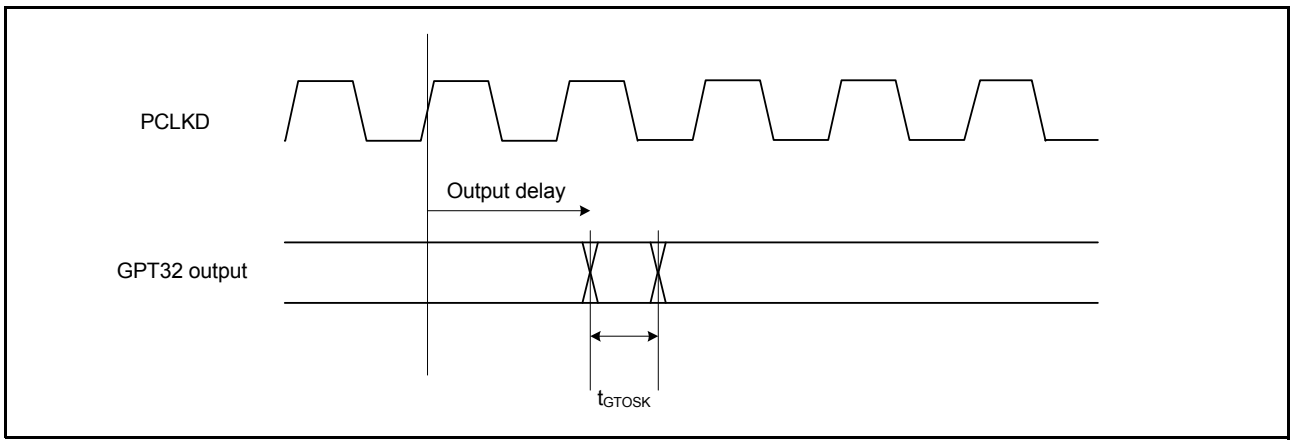


Figure 2.30 GPT32 output delay skew for OPS

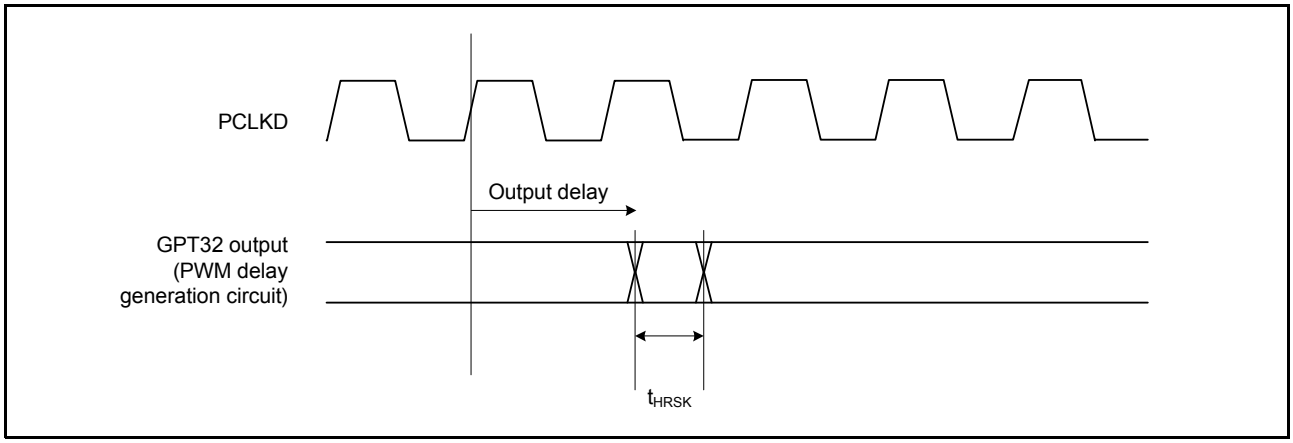


Figure 2.31 GPT32 (PWM Delay Generation Circuit) output delay skew

2.3.11 SPI Timing

Table 2.25 SPI timing

Conditions:
(1) Middle drive output is selected with the port drive capability bit in the PmnPFS register.
(2) Use pins that have a letter appended to their names, for instance "_A" or "_B", to indicate group membership. For the SPI interface, the AC portion of the electrical characteristics is measured for each group.

Item			Symbol	Min	Max	Unit*1	Test conditions
SPI	RSPCK clock cycle	Master	t_{SPcyc}	2 (PCLKA ≤ 60 MHz) 4 (PCLKA > 60 MHz)	4096	t_{Pcyc}	Figure 2.43 C = 30 pF
		Slave		6	4096		
	RSPCK clock high pulse width	Master	t_{SPCKWH}	$(t_{SPcyc} - t_{SPCKR} - t_{SPCKF}) / 2 - 3$	-	ns	
		Slave		$3 \times t_{Pcyc}$	-		
	RSPCK clock low pulse width	Master	t_{SPCKWL}	$(t_{SPcyc} - t_{SPCKR} - t_{SPCKF}) / 2 - 3$	-	ns	
		Slave		$3 \times t_{Pcyc}$	-		
	RSPCK clock rise and fall time	Master	t_{SPCKr}, t_{SPCKf}	-	5	ns	
		Slave		-	1	µs	
	Data input setup time	Master	t_{SU}	4	-	ns	Figure 2.44 to Figure 2.49 C = 30 pF
		Slave		5	-		
	Data input hold time	Master	t_{HF}*4	0	-	ns	-
		Master	t_H	t_{Pcyc}	-		
		Slave	t_H	20	-		-
	SSL setup time	Master	t_{LEAD}	$N \times t_{SPcyc}$ - 10*2	$N \times t_{SPcyc}$ + 100 *2	ns	-
		Slave		6 x t_{Pcyc}	-	ns	-
	SSL hold time	Master	t_{LAG}	$N \times t_{SPcyc}$ - 10 *3	$N \times t_{SPcyc}$ + 100 *3	ns	-
		Slave		6 x t_{Pcyc}	-	ns	-
	Data output delay	Master	t_{OD}	-	6.3	ns	Figure 2.44 to Figure 2.49 C = 30pF
		Slave		-	20		
	Data output hold time	Master	t_{OH}	0	-	ns	
		Slave		0	-		
	Successive transmission delay	Master	t_{TD}	$t_{SPcyc} + 2 \times t_{Pcyc}$	$8 \times t_{SPcyc} + 2 \times t_{Pcyc}$	ns	
		Slave		$6 \times t_{Pcyc}$			
	MOSI and MISO rise and fall time	Output	t_{Dr}, t_{Df}	-	5	ns	
		Input		-	1	µs	
	SSL rise and fall time	Output	t_{SSLr}, t_{SSLf}	-	5	ns	
		Input		-	1	µs	
	Slave access time		t_{SA}	-	2 x t_{Pcyc} + 28	ns	Figure 2.48 and Figure 2.49 C = 30pF
	Slave output release time		t_{REL}	-	2 x t_{Pcyc} + 28		

Note 1. t_{Pcyc}: PCLKA cycle.
Note 2. N is set to an integer from 1 to 8 by the SPCKD register.
Note 3. N is set to an integer from 1 to 8 by the SSLND register.
Note 4. PCLKA division ratio set to 1/2.

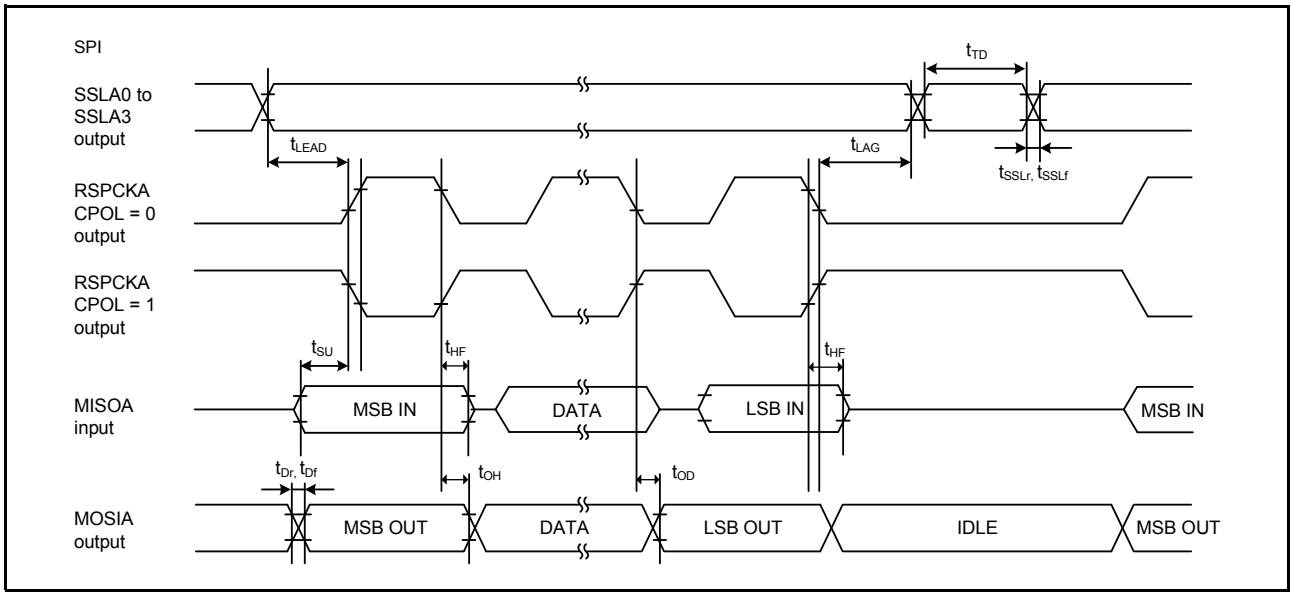


Figure 2.45 SPI timing for master when CPHA = 0 and the bit rate is set to PCLKA/2

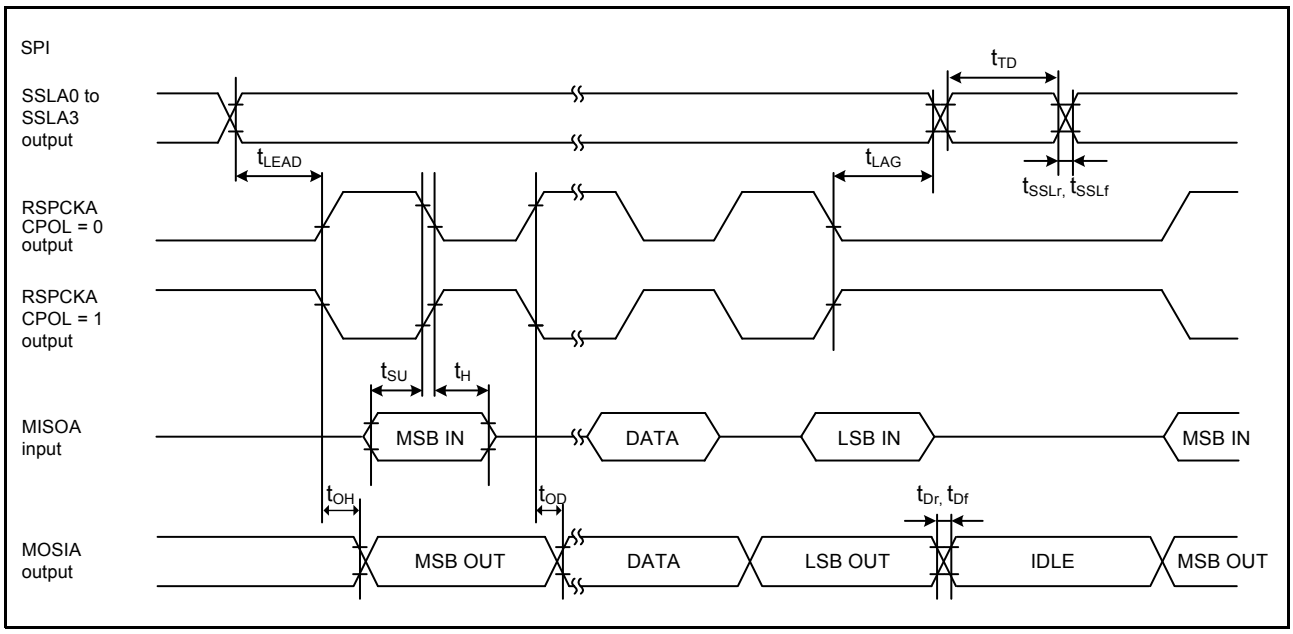


Figure 2.46 SPI timing for master when CPHA = 1 and the bit rate is set to PCLKA/2

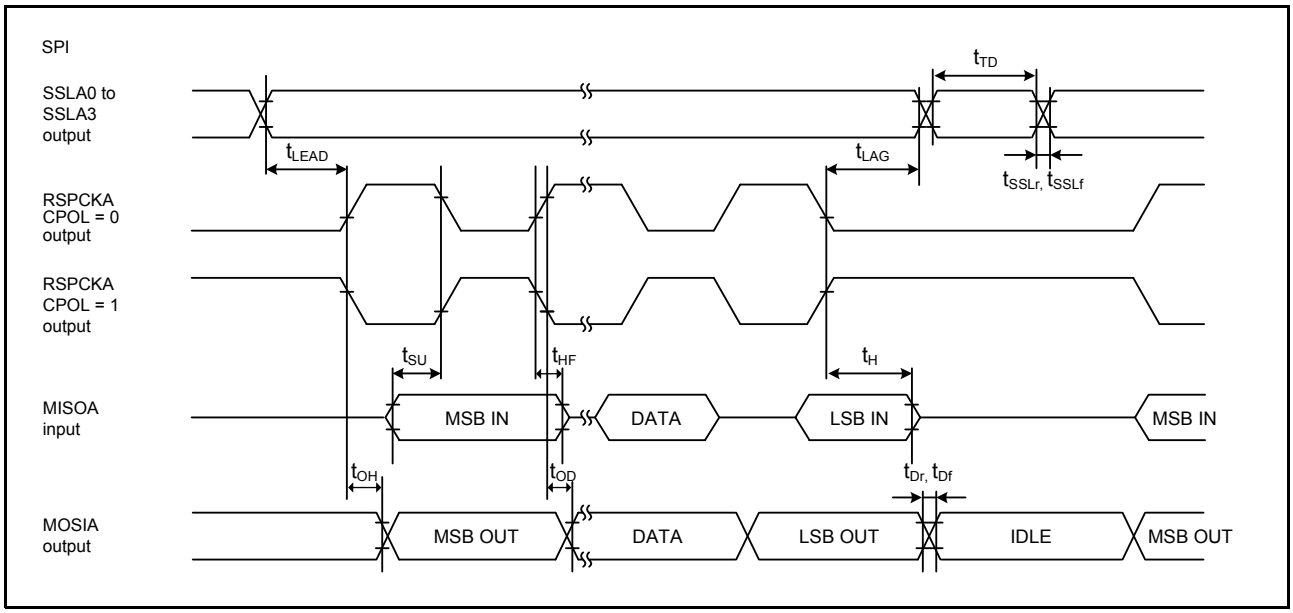


Figure 2.47 SPI timing for master when CPHA = 1 and the bit rate is set to PCLKA/2

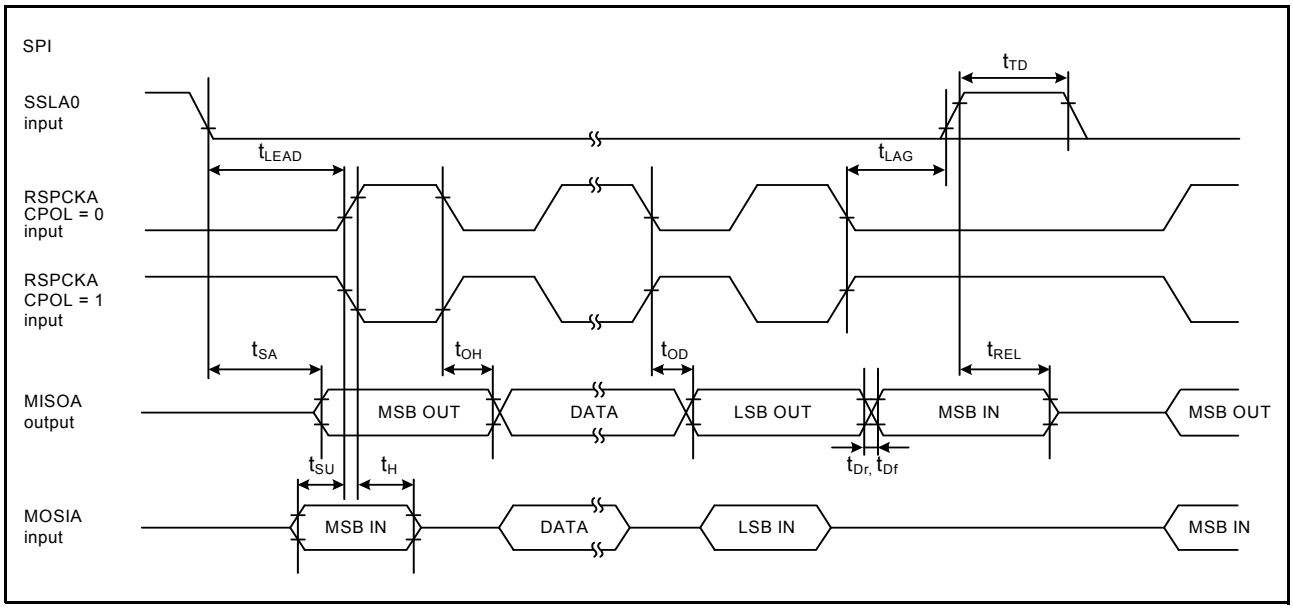


Figure 2.48 SPI timing for slave when CPHA = 0

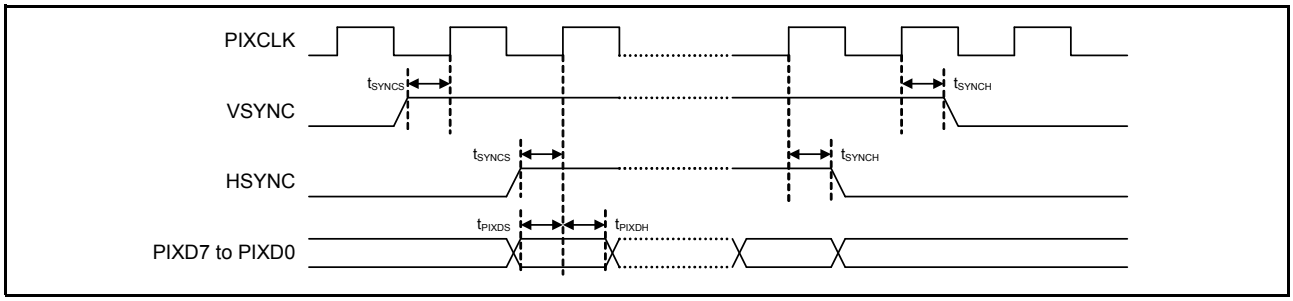


Figure 2.70 PDC AC timing

2.3.18 Graphics LCD Controller Timing

Table 2.33 Graphics LCD Controller timing
Conditions:
LCD_CLK: High drive output is selected in the port drive capability bit in the PmnPFS register.
LCD_DATA: Middle drive output is selected in the port drive capability bit in the PmnPFS register.

Item		Symbol	Min	Typ	Max	Unit	Test conditions
LCD_EXTCLK input clock frequency		t_{Ecyc}	-	-	60*1	MHz	Figure 2.71
LCD_EXTCLK input clock low pulse width		t_{WL}	0.45	-	0.55	t_{Ecyc}	
LCD_EXTCLK input clock high pulse width		t_{WH}	0.45	-	0.55		
LCD_CLK output clock frequency		t_{Lcyc}	-	-	60*1	MHz	Figure 2.72
LCD_CLK output clock low pulse width		t_{LOL}	0.4	-	0.6	t_{Lcyc}	Figure 2.72
LCD_CLK output clock high pulse width		t_{LOH}	0.4	-	0.6	t_{Lcyc}	Figure 2.72
LCD data output delay timing	_A or _B combinations*2	t_{DD}	–3.5	-	4	ns	Figure 2.73
	_A and _B combinations*3		–5.0	-	5.5		
LCD data output rise time (0.8 to 2.0 V)		t_{Dr}	-	-	2		Figure 2.74
LCD data output fall time (2.0 to 0.8 V)		t_{Df}	-	-	2		

Note 1. Parallel RGB888, 666,565: Maximum 54 MHz
Serial RGB888: Maximum 60 MHz (4x speed)
Note 2. Use pins that have a letter appended to their names, for instance, “_A” or “_B”, to indicate
Note 3. Pins of group“_A” and “_B” combinations are used.

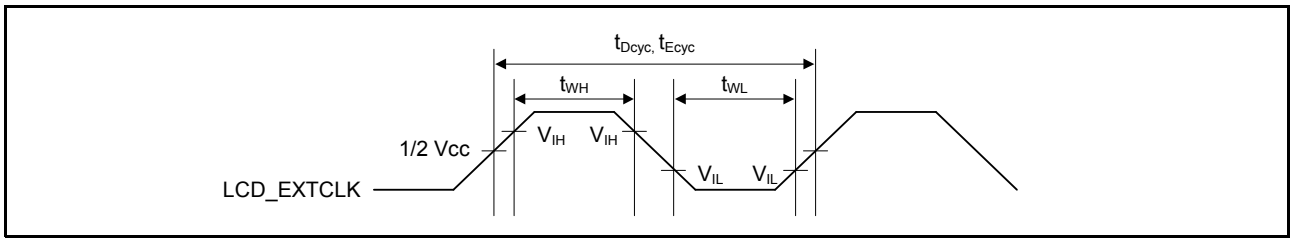


Figure 2.71 LCD_EXTCLK clock input timing

2.4.2 USBFS Timing

Table 2.38 USBFS low-speed characteristics for host only (USB_DP and USB_DM pin characteristics)
Conditions: VCC = AVCC0 = VCC_USB = VBATT = 3.0 to 3.6V, 2.7 ≤ VREFH0/VREFH ≤ AVCC0, VCC_USBHS = AVCC_USBHS = 3.0 to 3.6 V, USBA_RREF = 2.2 kΩ ±1%, USBMCLK = 20/24 MHz, UCLK = 48 MHz

Item		Symbol	Min	Typ	Max	Unit	Test conditions
Input characteristics	Input high voltage	V_{IH}	2.0	-	-	V	-
	Input low voltage	V_{IL}	-	-	0.8	V	-
	Differential input sensitivity	V_{DI}	0.2	-	-	V	| USB_DP - USB_DM |
	Differential common-mode range	V_{CM}	0.8	-	2.5	V	-
Output characteristics	Output high voltage	V_{OH}	2.8	-	3.6	V	I_{OH} = –200 µA
	Output low voltage	V_{OL}	0.0	-	0.3	V	I_{OL}= 2 mA
	Cross-over voltage	V_{CRS}	1.3	-	2.0	V	Figure 2.83
	Rise time	t_{LR}	75	-	300	ns	
	Fall time	t_{LF}	75	-	300	ns	
	Rise/fall time ratio	t_{LR} / t_{LF}	80	-	125	%	t_{LR}/ t_{LF}
Pull-up and pull-down characteristics	USB_DP and USB_DM pull-down resistance in host controller mode	R_{pd}	14.25	-	24.80	kΩ	-

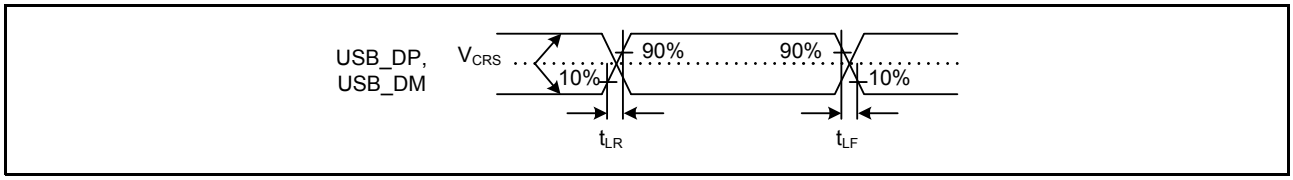


Figure 2.83 USB_DP and USB_DM output timing in low-speed mode

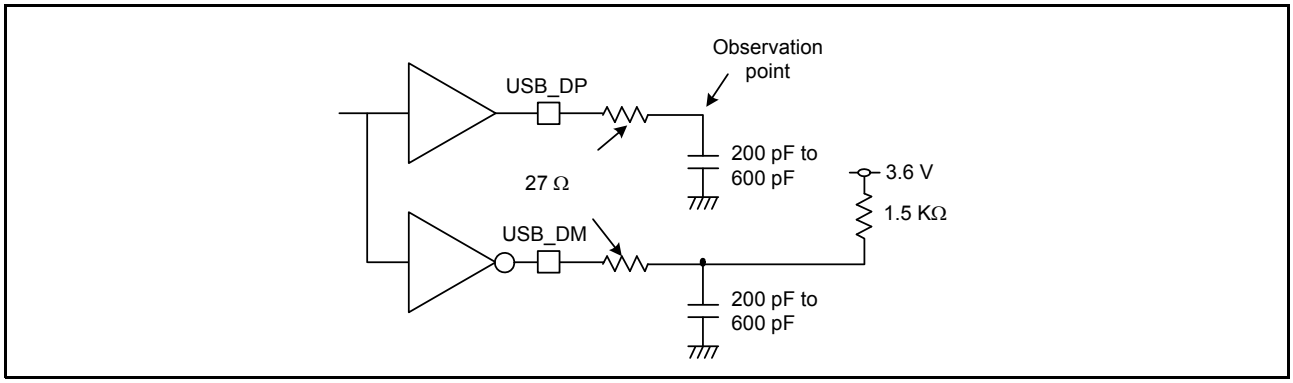


Figure 2.84 Test circuit in low-speed mode

Table 2.39 USBFS full-speed characteristics (USB_DP and USB_DM pin characteristics) (1/2)
Conditions: VCC = AVCC0 = VCC_USB = VBATT = 3.0 to 3.6 V, 2.7 ≤ VREFH0/VREFH ≤ AVCC0, VCC_USBHS = AVCC_USBHS = 3.0 to 3.6 V, USBA_RREF = 2.2 kΩ ±1%, USBMCLK = 20/24 MHz, UCLK = 48 MHz

Item		Symbol	Min	Typ	Max	Unit	Test conditions
Input characteristics	Input high voltage	V_{IH}	2.0	-	-	V	-
	Input low voltage	V_{IL}	-	-	0.8	V	-
	Differential input sensitivity	V_{DI}	0.2	-	-	V	| USB_DP - USB_DM |
	Differential common-mode range	V_{CM}	0.8	-	2.5	V	-

2.9 POR and LVD Characteristics

Table 2.46 Power-on reset circuit and voltage detection circuit characteristics

Item			Symbol	Min	Typ	Max	Unit	Test conditions
Voltage detection level	Power-on reset (POR)	Module-stop function disabled*1	V_{POR}	2.5	2.6	2.7	V	Figure 2.89
		Module-stop function enabled*2		2.0	2.35	2.7		
	Voltage detection circuit (LVD0)		V_{det0_1}	2.84	2.94	3.04		Figure 2.90
			V_{det0_2}	2.77	2.87	2.97		
			V_{det0_3}	2.70	2.80	2.90		
	Voltage detection circuit (LVD1)		V_{det1_1}	2.89	2.99	3.09		Figure 2.91
			V_{det1_2}	2.82	2.92	3.02		
			V_{det1_3}	2.75	2.85	2.95		
	Voltage detection circuit (LVD2)		V_{det2_1}	2.89	2.99	3.09		Figure 2.92
			V_{det2_2}	2.82	2.92	3.02		
			V_{det2_3}	2.75	2.85	2.95		
Internal reset time	Power-on reset time		t_{POR}	-	4.6	-	ms	Figure 2.89
	LVD0 reset time		t_{LVD0}	-	0.70	-		Figure 2.90
	LVD1 reset time		t_{LVD1}	-	0.57	-		Figure 2.91
	LVD2 reset time		t_{LVD2}	-	0.57	-		Figure 2.92
Minimum VCC down time			t_{VOFF}	200	-	-	µs	Figure 2.89, Figure 2.90
Response delay			t_{det}	-	-	200	µs	Figure 2.89 to Figure 2.92
LVD operation stabilization time (after LVD is enabled)			$T_{d(E-A)}$	-	-	10	µs	Figure 2.91, Figure 2.92
Hysteresis width (LVD1 and LVD2)			V_{LVH}	-	80	-	mV	

Note 1. The minimum VCC down time indicates the time when VCC is below the minimum value of voltage detection levels V_{POR}, V_{det1}, and V_{det2} for POR and LVD.
Note 2. The low-power function is disabled and DEEPCUT[1:0] = 00b or 01b.
Note 3. The low-power function is enabled and DEEPCUT[1:0] = 11b.

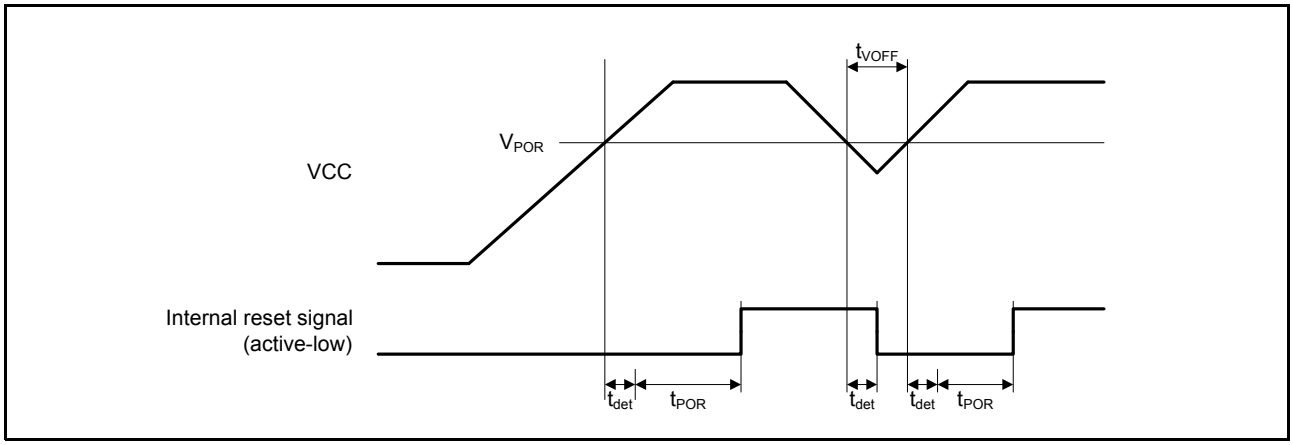
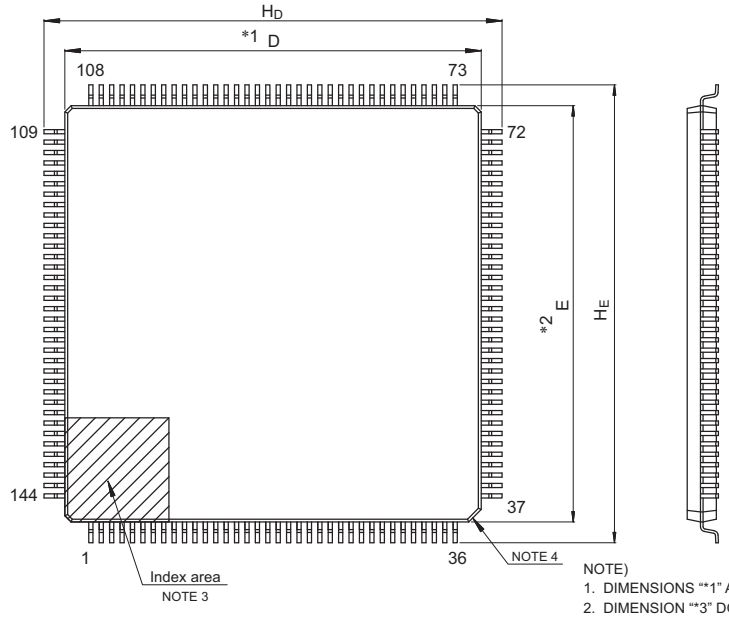


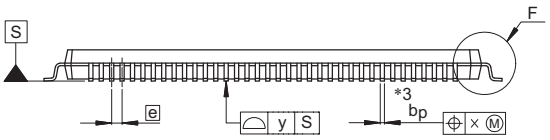
Figure 2.89 Power-on reset timing

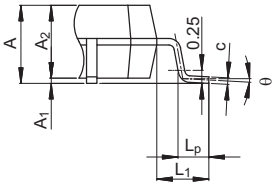
JEITA Package Code	RENESAS Code	Previous Code	MASS (Typ) [g]
P-LFQFP144-20x20-0.50	PLQP0144KA-B	—	1.2

Unit: mm



NOTE)
1. DIMENSIONS "*1" AND "*2" DO NOT INCLUDE MOLD FLASH.
2. DIMENSION "*3" DOES NOT INCLUDE TRIM OFFSET.
3. PIN 1 VISUAL INDEX FEATURE MAY VARY, BUT MUST BE LOCATED WITHIN THE HATCHED AREA.
4. CHAMFERS AT CORNERS ARE OPTIONAL, SIZE MAY VARY.





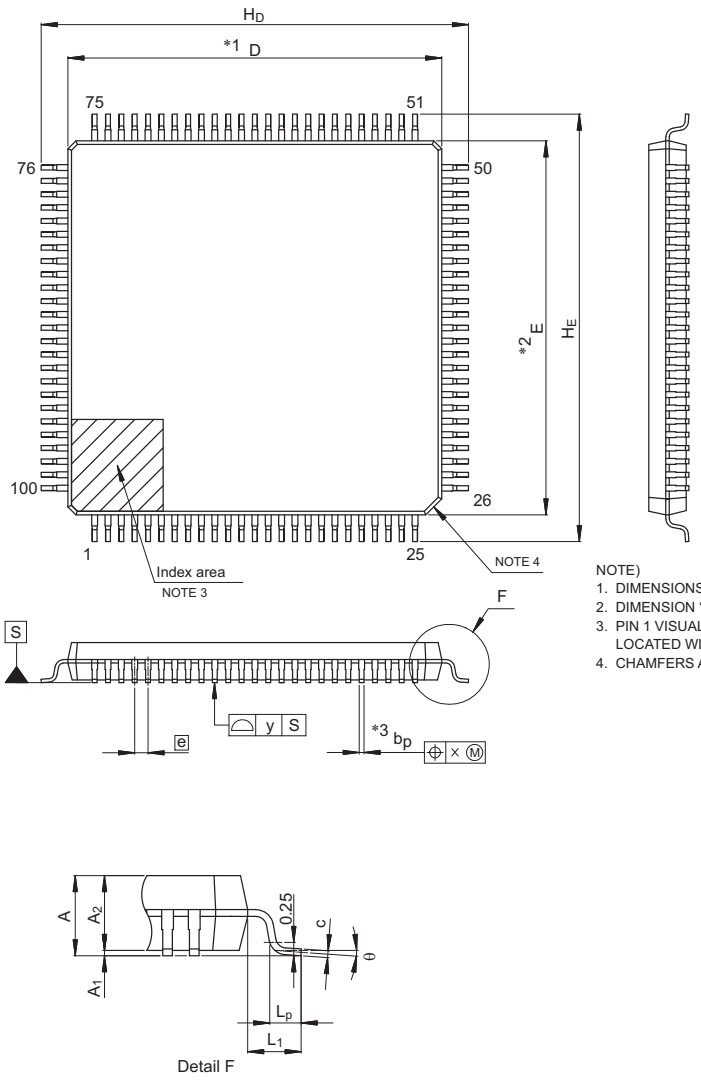
Detail F

Reference Symbol	Dimensions in millimeters		
	Min	Nom	Max
D	19.9	20.0	20.1
E	19.9	20.0	20.1
A_2	—	1.4	—
H_D	21.8	22.0	22.2
H_E	21.8	22.0	22.2
A	—	—	1.7
A_1	0.05	—	0.15
b_p	0.17	0.20	0.27
c	0.09	—	0.20
θ	0°	3.5°	8°
e	—	0.5	—
x	—	—	0.08
y	—	—	0.08
L_p	0.45	0.6	0.75
L_1	—	1.0	—

Figure 1.5 144-pin LQFP

JEITA Package Code	RENESAS Code	Previous Code	MASS (Typ) [g]
P-LFQFP100-14x14-0.50	PLQP0100KB-B	—	0.6

Unit: mm



NOTE)
1. DIMENSIONS "*1" AND "*2" DO NOT INCLUDE MOLD FLASH.
2. DIMENSION "*3" DOES NOT INCLUDE TRIM OFFSET.
3. PIN 1 VISUAL INDEX FEATURE MAY VARY, BUT MUST BE LOCATED WITHIN THE HATCHED AREA.
4. CHAMFERS AT CORNERS ARE OPTIONAL, SIZE MAY VARY.

Reference Symbol	Dimensions in millimeters		
	Min	Nom	Max
D	13.9	14.0	14.1
E	13.9	14.0	14.1
A_2	—	1.4	—
H_D	15.8	16.0	16.2
H_E	15.8	16.0	16.2
A	—	—	1.7
A_1	0.05	—	0.15
b_p	0.15	0.20	0.27
c	0.09	—	0.20
θ	0°	3.5°	8°
e	—	0.5	—
x	—	—	0.08
y	—	—	0.08
L_p	0.45	0.6	0.75
L_1	—	1.0	—

Figure 1.6 100-pin LQFP